



YEA SHIN TECHNOLOGY CO., LTD

YS80N03D

N-Channel Enhancement MOSFET



V_{DS}= 30V, I_D= 80A

DESCRIPTION

The YS80N03D is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent R_{DS(ON)} and gate charge for most of the synchronous buck converter applications.

FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

MARKING



PACKAGE INFORMATION

Package	MPQ	Leader Size
TO-252	2.5K	13 inch

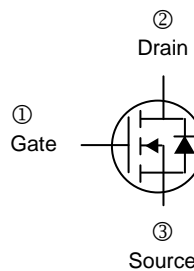
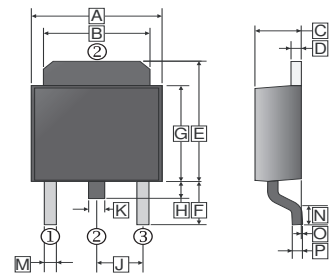
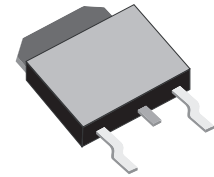
ORDER INFORMATION

Part Number	Type
YS80N03D	Lead (Pb)-free and Halogen-free

ABSOLUTE MAXIMUM RATINGS (T_A=25°C unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current ¹	I _D	V _{GS} =10V, T _C =25°C	80
		V _{GS} =10V, T _C =100°C	57
Pulsed Drain Current ²	I _{DM}	160	A
Total Power Dissipation ⁴	P _D	59	W
Linear Derating Factor		0.5	W / °C
Single Pulse Avalanche Energy ³	E _{AS}	98	mJ
Single Pulse Avalanche Current	I _{AS}	14	A
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55~150	°C
Thermal Resistance Rating			
Maximum Thermal Resistance Junction-Ambient ¹	R _{θJA}	62	°C / W
Maximum Thermal Resistance Junction-Case ¹	R _{θJC}	2.1	°C / W

TO-252(D-Pack)



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	6.3	6.9	J	2.3	REF.
B	4.95	5.53	K	0.89	REF.
C	2.1	2.5	M	0.45	1.14
D	0.4	0.9	N	1.55	Typ.
E	6	7.7	O	0	0.15
F	2.90	REF.	P	0.58	REF.
G	5.4	6.4			
H	0.6	1.2			

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ELECTRICAL CHARACTERISTICS (T_J=25°C unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Static							
Drain-Source Breakdown Voltage	BV _{DSS}	30	-	-	V	V _{GS} =0, I _D =250μA	
Gate-Threshold Voltage	V _{GS(th)}	1.0	-	2.5	V	V _{DS} =V _{GS} , I _D =250μA	
Forward Transconductance	g _{fs}	-	43	-	S	V _{DS} =5V, I _D =30A	
Gate-Source Leakage Current	I _{GSS}	-	-	±100	nA	V _{GS} =±20V	
Drain-Source Leakage Current	I _{DSS}	T _J =25°C	-	-	1	μA	V _{DS} =24V, V _{GS} =0
		T _J =55°C	-	-	5		V _{DS} =24V, V _{GS} =0
Static Drain-Source On-Resistance ²	R _{DS(ON)}	-	-	5.5	mΩ	V _{GS} =10V, I _D =30A	
		-	-	8		V _{GS} =4.5V, I _D =15A	
Total Gate Charge	Q _g	-	20	-	nC	I _D =15A V _{DS} =15V V _{GS} =4.5V	
Gate-Source Charge	Q _{gs}	-	7.6	-			
Gate-Drain ("Miller") Change	Q _{gd}	-	7.2	-			
Turn-on Delay Time	T _{d(on)}	-	7.8	-	nS	V _{DD} =15V I _D =15A V _{GS} =10V R _G =3.3 Ω	
Rise Time	T _r	-	15	-			
Turn-off Delay Time	T _{d(off)}	-	37.3	-			
Fall Time	T _f	-	10.6	-			
Input Capacitance	C _{iss}	-	2295	-	pF	V _{GS} =0 V _{DS} =15V f=1.0MHz	
Output Capacitance	C _{oss}	-	267	-			
Reverse Transfer Capacitance	C _{rss}	-	210	-			
Source-Drain Diode							
Diode Forward Voltage ²	V _{SD}	-	-	1	V	I _S =1A, V _{GS} =0	
Continuous Source Current ^{1,5}	I _S	-	-	80	A	V _D =V _G =0, Force Current	
Pulsed Source Current ^{2,5}	I _{SM}	-	-	160	A		
Reverse Recovery Time	T _{rr}	-	14	-	nS	I _F =30A, di/dt=100A/μS	
Reverse Recovery Charge	Q _{rr}	-	5	-	nC	T _J =25°C	

Notes:

- The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- The data tested by pulsed , pulse width ≤ 300μs , duty cycle ≤ 2%
- The EAS data shows Max. rating . The test condition is V_{DD}=25V, V_{GS}=10V, L=1mH, I_{AS}=14A
- The power dissipation is limited by 150°C junction temperature
- The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

DEVICE CHARACTERISTICS

YS80N03D

CHARACTERISTIC CURVES

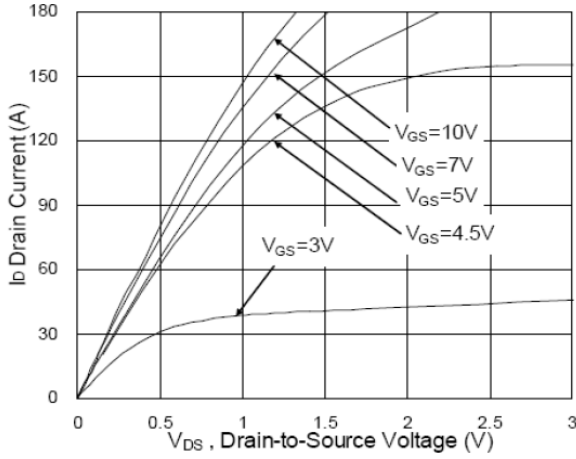


Fig.1 Typical Output Characteristics

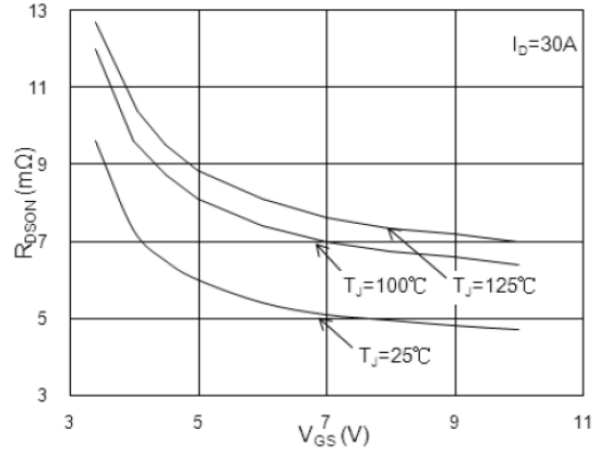


Fig.2 On-Resistance vs. G-S Voltage

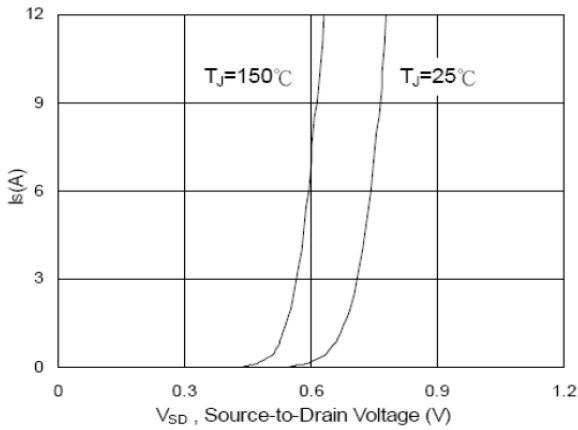


Fig.3 Forward Characteristics of Reverse

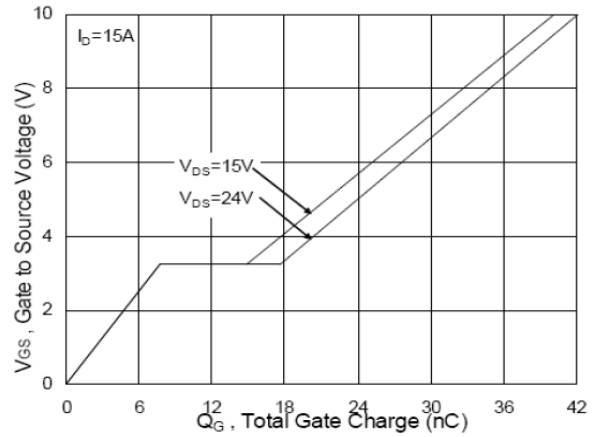


Fig.4 Gate-Charge Characteristics

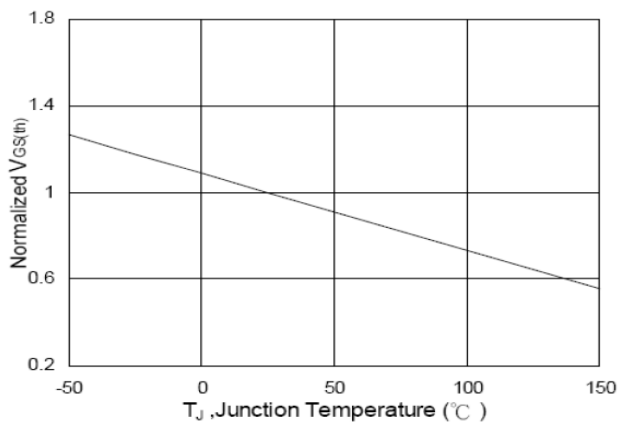


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

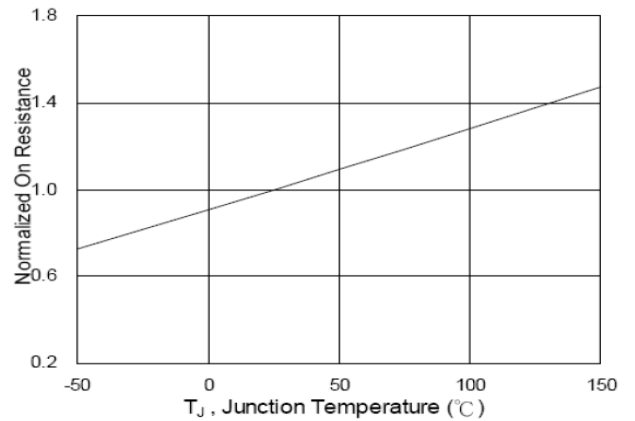


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

DEVICE CHARACTERISTICS

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CHARACTERISTIC CURVES

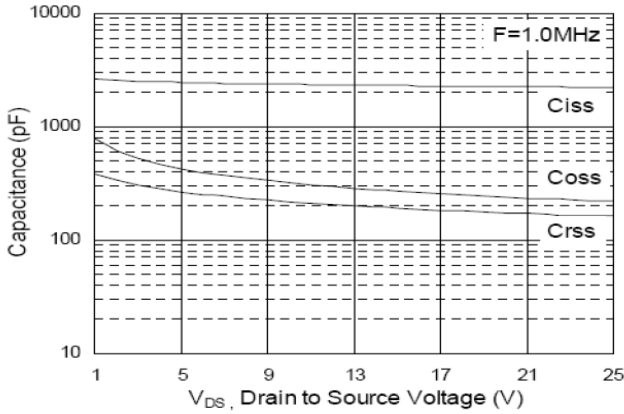


Fig.7 Capacitance

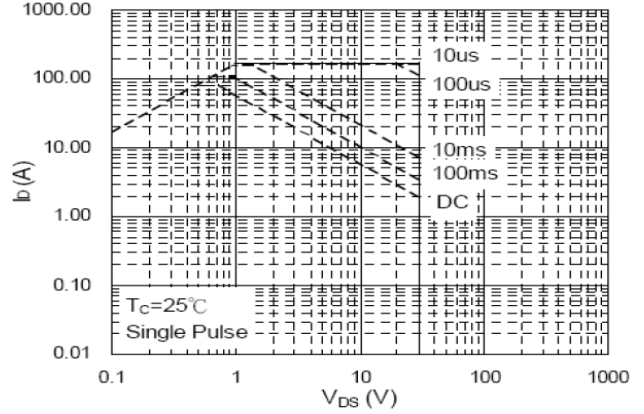


Fig.8 Safe Operating Area

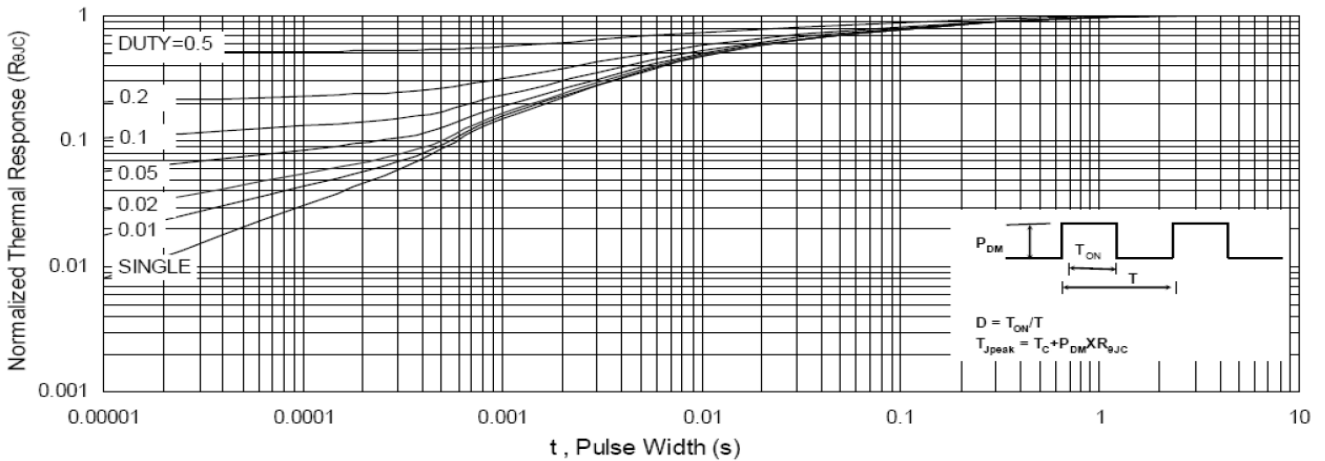


Fig.9 Normalized Maximum Transient Thermal Impedance

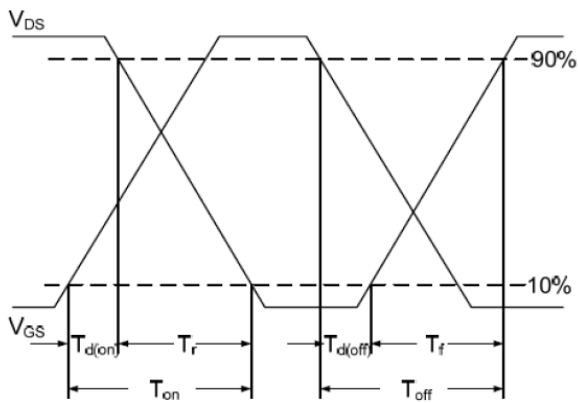


Fig.10 Switching Time Waveform

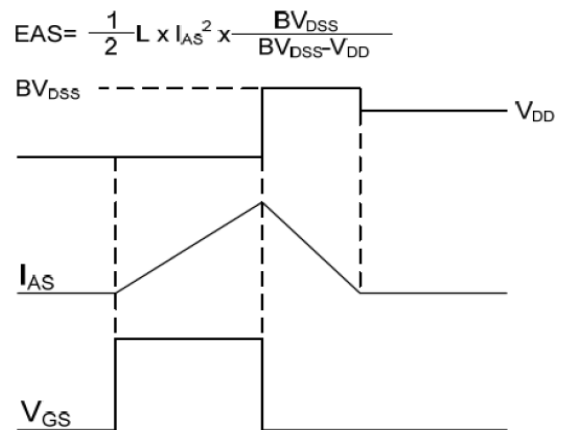


Fig.11 Unclamped Inductive Switching Waveform